Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,300	WU ET AL.	
Examiner	Art Unit	
Alain L. Bashore	1762	

	SEAR	CHED	
Class	Subclass	Date	Examiner
427	8, 425, 162, 240	9/25/2006	AB
118	715	9/25/2006	ab
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ראו	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (attached)	9/25/2006	АВ	
Inventor search	9/25/2006	АВ	